



HIGH VOLTAGE SILICON PLANAR TRANSISTORS

P-N-P high voltage silicon planar transistors in plastic TO-92 envelope for general purpose applications.

QUICK REFERENCE DATA

		MPSA92	MPSA93
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	300 200 V
Collector-base voltage (open emitter)	$-V_{CBO}$	max.	300 200 V
Collector current (d.c.)	$-I_C$	max.	500 mA
Total device dissipation at $T_{amb} = 25^\circ\text{C}$	P_{tot}	max.	625 mW
Collector-emitter saturation voltage $-I_C = 20 \text{ mA}; -I_B = 2,0 \text{ mA}$	$-V_{CEsat}$	max.	0,5 V
D.C. current gain $-I_C = 30 \text{ mA}; -V_{CE} = 10 \text{ V}$	h_{FE}	min.	25

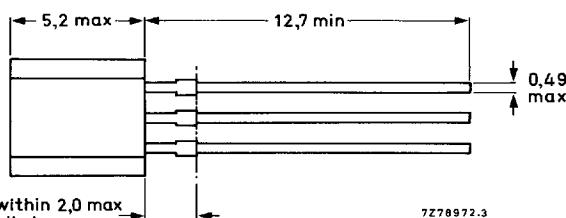
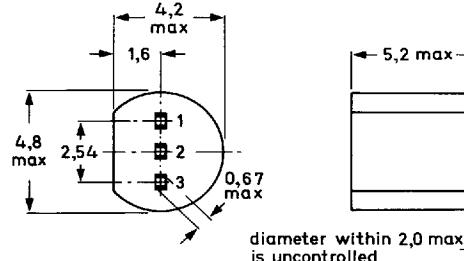
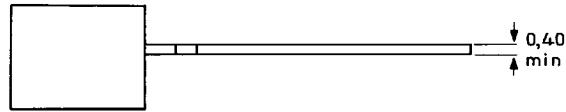
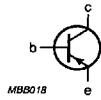
MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-92.

Pinning

- 1 = collector
- 2 = base
- 3 = emitter



■ Capability approved to CECC NECC-C-002

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		MPSA92	MPSA93	
Collector-emitter voltage (open base)	VCEO	max.	300	200 V
Collector-base voltage (open emitter)	VCBO	max.	300	200 V
Emitter-base voltage (open collector)	VEBO	max.	5,0	V
Collector current (d.c.)	I _C	max.	500	mA
Total device dissipation at T _{amb} = 25 °C	P _{tot}	max.	625	mW
Storage temperature range	T _{stg}		-65 to +150	°C
Junction temperature	T _j	max.	150	°C

THERMAL RESISTANCE

From junction to ambient	R _{th j-a}	=	200	K/W
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CHARACTERISTICST_j = 25 °C unless otherwise specified

Collector-emitter breakdown voltage I _B = 0; -I _C = 1,0 mA	-V _{(BR)CEO}	min.	300	200 V
Collector-base breakdown voltage I _E = 0; -I _C = 100 μA	-V _{(BR)CBO}	min.	300	200 V
Emitter-base breakdown voltage I _C = 0; -I _E = 100 μA	-V _{(BR)EBO}	min.	5,0	V
Collector cut-off current I _E = 0; -V _{CB} = 200 V	-I _{CBO}	max.	0,25	μA
	-I _{CBO}	max.		0,25 μA
Collector cut-off current I _C = 0; -V _{BE} = 3,0 V	-I _{EBO}	max.	0,1	μA
D.C. current gain*				
-I _C = 1,0 mA; -V _{CE} = 10 V	h _{FE}	min.	25	
-I _C = 10 mA; -V _{CE} = 10 V	h _{FE}	min.	40	
-I _C = 30 mA; -V _{CE} = 10 V	h _{FE}	min.	25	
Saturation voltages*				
-I _C = 20 mA; -I _B = 2,0 mA	-V _{CESat}	max.	0,5	V
-I _C = 20 mA; -I _B = 2,0 mA	-V _{BESat}	max.	0,9	V
Transition frequency at f = 100 MHz -I _C = 10 mA; -V _{CE} = 20 V	f _T	min.	50	MHz
Collector-base capacitance at f = 1 MHz -V _{CB} = 20 V; I _E = 0	C _{c_b}	max.	6,0	8,0 pF

* Pulse test: pulse width ≤ 300 μs, duty cycle ≤ 2%.